

Product Summary

$V_{(BR)DSS}$	$R_{DS(ON)} \text{ max}$	$I_D \text{ max}$ $T_A = 25^\circ\text{C}$
20V	0.99Ω @ $V_{GS} = 4.5\text{V}$	760mA
	1.2Ω @ $V_{GS} = 2.5\text{V}$	700mA
	2.4Ω @ $V_{GS} = 1.8\text{V}$	500mA
	3.0Ω @ $V_{GS} = 1.5\text{V}$	350mA

Description and Applications

This MOSFET has been designed to minimize the on-state resistance ($R_{DS(on)}$) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

- General Purpose Interfacing Switch
- Power Management Functions
- Analog Switch

Features and Benefits

- Low On-Resistance
- Very low Gate Threshold Voltage, 1.0V max
- Low Input Capacitance
- Fast Switching Speed
- Ultra-Small Surface Mount Package 1mm x 0.6mm
- Low Package Profile, 0.5mm Maximum Package height
- ESD Protected Gate
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)**
- Halogen and Antimony Free. "Green" Device (Note 3)**
- Qualified to AEC-Q101 standards for High Reliability**

Mechanical Data

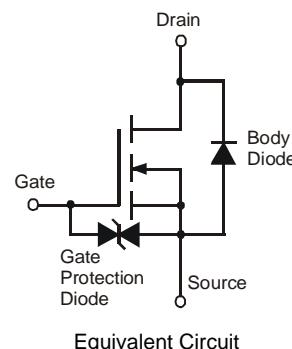
- Case: X1-DFN1006-3
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminal Connections Indicator: See diagram
- Terminals: Finish – NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208 
- Weight: 0.001 grams (approximate)



Bottom View



Top View
Package Pin Configuration



Ordering Information (Note 4)

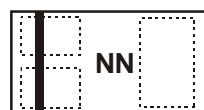
Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN21D2UFB-7B	NN	7	8	10,000

Notes:

- No purposely added lead. Fully EU Directive 2002/95/EC (RoHS) & 2011/65/EU (RoHS 2) compliant.
- See <http://www.diodes.com> for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free.
- Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- For packaging details, go to our website at <http://www.diodes.com>.

Marking Information

DMN21D2UFB-7B



NN = Product Type Marking Code

Top View
Bar Denotes Gate and Source Side

Maximum Ratings @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	20	V
Gate-Source Voltage			V_{GSS}	± 12	V
Continuous Drain Current (Note 6) $V_{GS} = 4.5\text{V}$	Steady State	$T_A = 25^\circ\text{C}$	I_D	760	mA
	$t < 5\text{s}$	$T_A = 70^\circ\text{C}$	I_D	610	
Maximum Continuous Body Diode Forward Current (Note 6)			I_S	850	mA
Pulsed Drain Current (Note 7)			I_{DM}	700	
Maximum Continuous Body Diode Forward Current (Note 6)			I_S	0.8	A
Pulsed Drain Current (Note 7)			I_{DM}	1.0	A

Thermal Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic			Symbol	Value	Units
Total Power Dissipation (Note 4)		$T_A = 25^\circ\text{C}$	P_D	0.38	W
		$T_A = 70^\circ\text{C}$		0.25	
Thermal Resistance, Junction to Ambient (Note 4)		Steady State	$R_{\theta JA}$	325	°C/W
		$t < 5\text{s}$		244	
Total Power Dissipation (Note 5)		$T_A = 25^\circ\text{C}$	P_D	0.9	W
		$T_A = 70^\circ\text{C}$		0.57	
Thermal Resistance, Junction to Ambient (Note 5)		Steady State	$R_{\theta JA}$	141	°C/W
		$t < 5\text{s}$		106	
Operating and Storage Temperature Range			T_J, T_{STG}	-55 to 150	°C

Electrical Characteristics @ $T_A = 25^\circ\text{C}$ unless otherwise specified

Characteristic	Symbol	Min	Typ	Max	Unit	Test Condition
OFF CHARACTERISTICS (Note 8)						
Drain-Source Breakdown Voltage	BV_{DSS}	20	-	-	V	$V_{GS} = 0\text{V}, I_D = 250\mu\text{A}$
Zero Gate Voltage Drain Current @ $T_c = 25^\circ\text{C}$	I_{DSS}	-	-	100	nA	$V_{DS} = 20\text{V}, V_{GS} = 0\text{V}$
Gate-Source Leakage	I_{GSS}	-	-	± 1	μA	$V_{GS} = \pm 10\text{V}, V_{DS} = 0\text{V}$
ON CHARACTERISTICS (Note 8)						
Gate Threshold Voltage	$V_{GS(th)}$	0.4	-	1.0	V	$V_{DS} = V_{GS}, I_D = 250\mu\text{A}$
Static Drain-Source On-Resistance	$R_{DS(\text{ON})}$	-	0.6	0.99	Ω	$V_{GS} = 4.5\text{V}, I_D = 100\text{mA}$
		-	0.7	1.2		$V_{GS} = 2.5\text{V}, I_D = 50\text{mA}$
		-	0.9	2.4		$V_{GS} = 1.8\text{V}, I_D = 20\text{mA}$
		-	1.2	3.0		$V_{GS} = 1.5\text{V}, I_D = 10\text{mA}$
		180	-	-	mS	$V_{DS} = 10\text{V}, I_D = 400\text{mA}$
Diode Forward Voltage	V_{SD}	-	0.6	1.0	V	$V_{GS} = 0\text{V}, I_S = 150\text{mA}$
DYNAMIC CHARACTERISTICS (Note 9)						
Input Capacitance	C_{iss}	-	27.6	-	pF	$V_{DS} = 16\text{V}, V_{GS} = 0\text{V}, f = 1.0\text{MHz}$
Output Capacitance	C_{oss}	-	4.0	-	pF	
Reverse Transfer Capacitance	C_{rss}	-	2.8	-	pF	
Total Gate Charge $V_{GS} = 4.5\text{V}$	Q_g	-	0.41	-	nC	
Total Gate Charge $V_{GS} = 10\text{V}$	Q_g	-	0.93	-	nC	
Gate-Source Charge	Q_{gs}	-	0.06	-	nC	$V_{DS} = 10\text{V}, I_D = 250\text{mA}$
Gate-Drain Charge	Q_{gd}	-	0.06	-	nC	
Turn-On Delay Time	$t_{D(on)}$	-	3.5	-	ns	
Turn-On Rise Time	t_r	-	4.2	-	ns	
Turn-Off Delay Time	$t_{D(off)}$	-	19.6	-	ns	
Turn-Off Fall Time	t_f	-	9.8	-	ns	$V_{DD} = 10\text{V}, V_{GS} = 4.5\text{V}, R_L = 47\Omega, R_G = 10\Omega, I_D = 200\text{mA}$

Notes:

5. Device mounted on FR-4 PCB, with minimum recommended pad layout.
6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal vias to bottom layer 1inch square copper plate
7. Device mounted on minimum recommended pad layout test board, 10 μs pulse duty cycle = 1%.
8. Short duration pulse test used to minimize self-heating effect.
9. Guaranteed by design. Not subject to product testing.

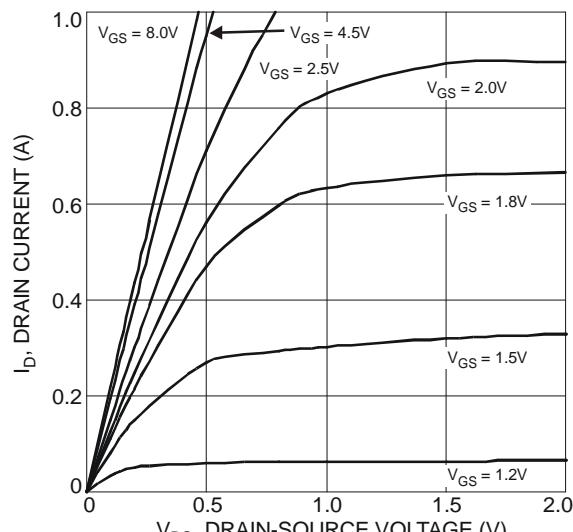


Fig. 1 Typical Output Characteristic

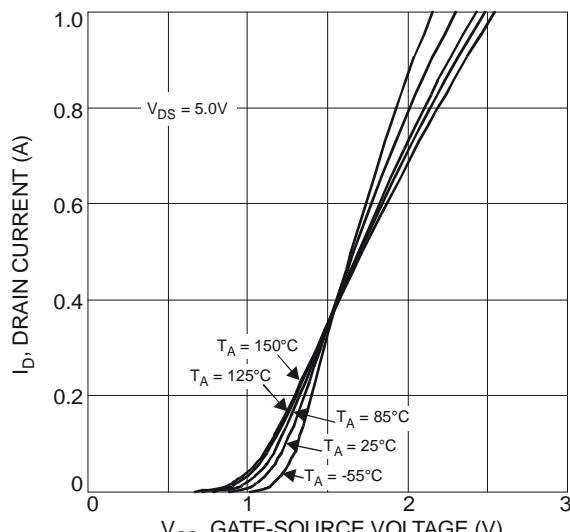


Fig. 2 Typical Transfer Characteristics

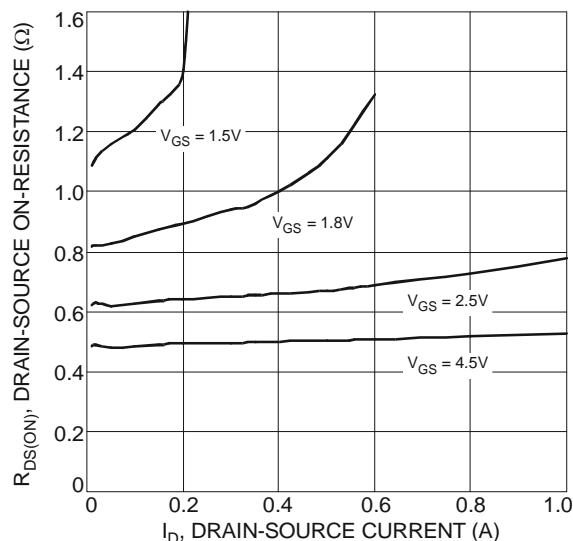


Fig. 3 Typical On-Resistance vs.
Drain Current and Gate Voltage

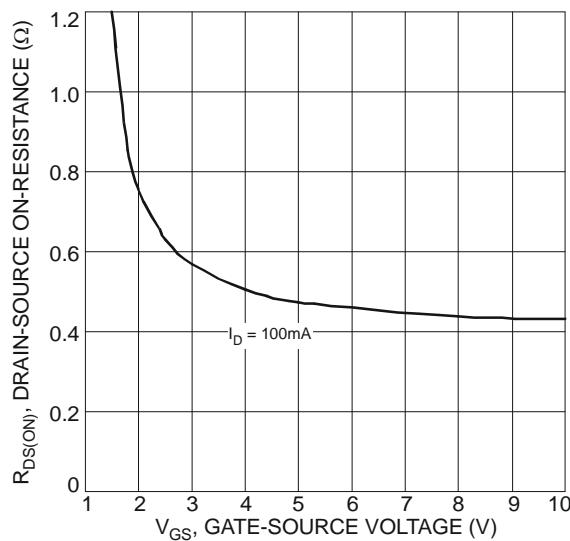


Fig. 4 Typical Drain-Source On-Resistance
vs. Gate-Source Voltage

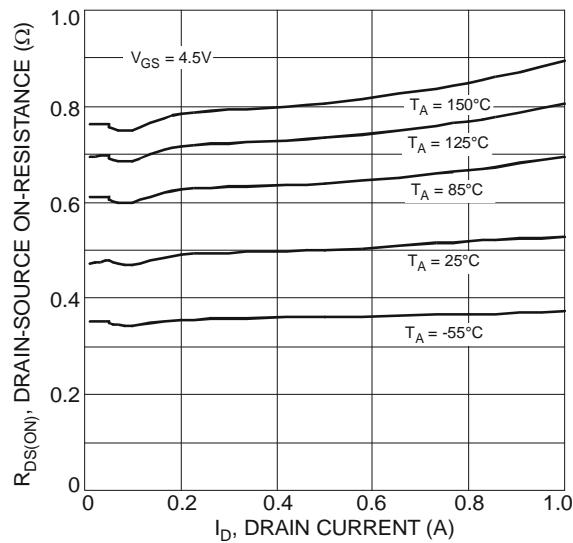


Fig. 5 Typical On-Resistance vs.
Drain Current and Temperature

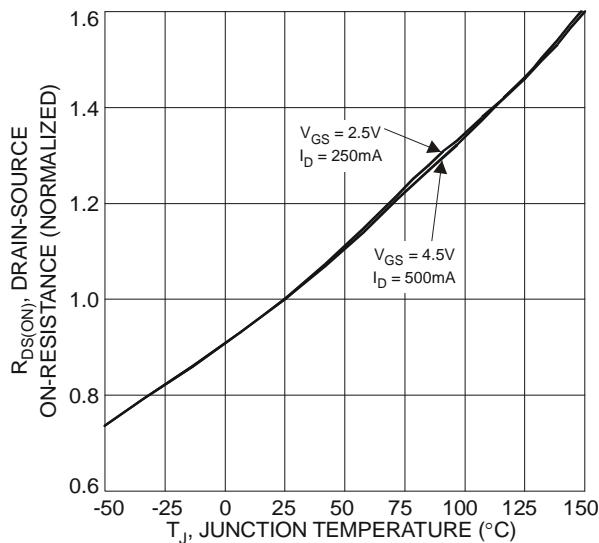


Fig. 6 On-Resistance Variation with Temperature

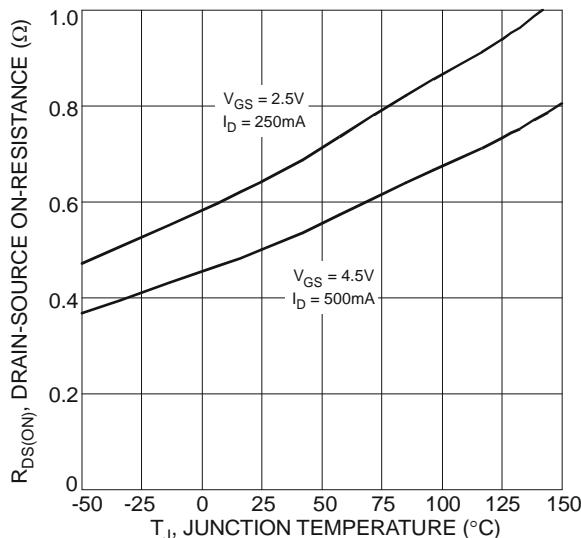


Fig. 7 On-Resistance Variation with Temperature

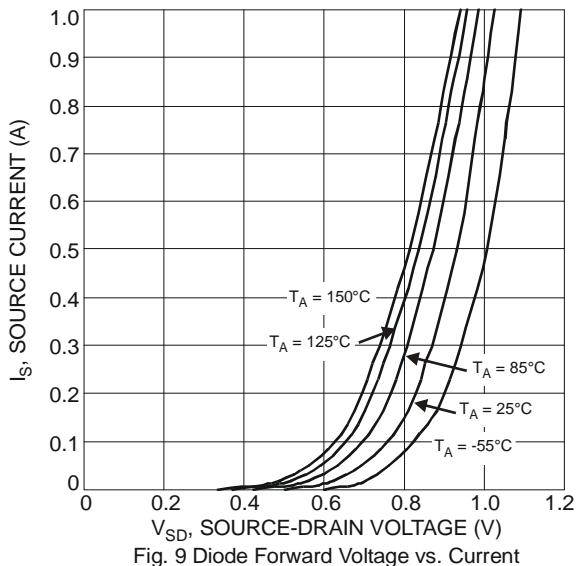


Fig. 9 Diode Forward Voltage vs. Current

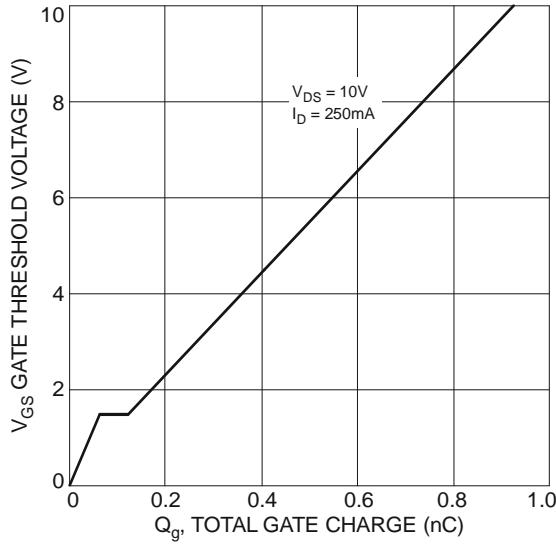


Fig. 11 Gate Charge

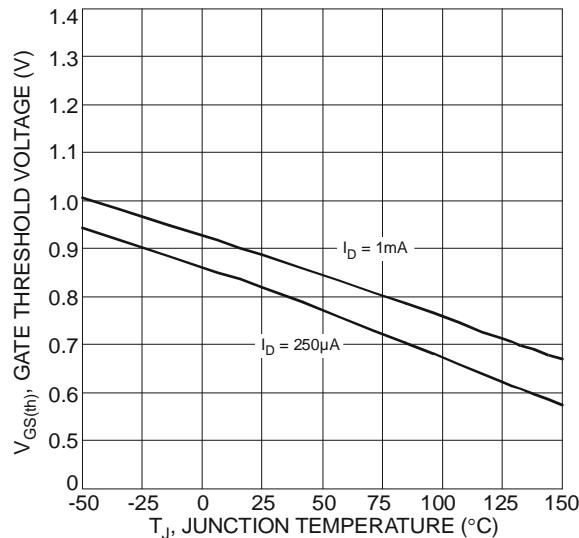


Fig. 8 Gate Threshold Variation vs. Ambient Temperature

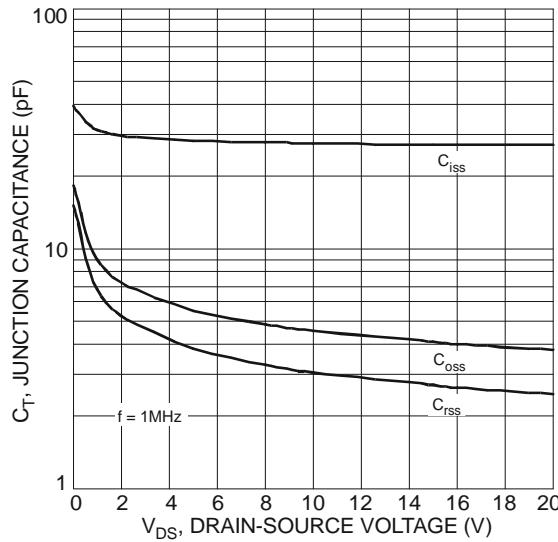


Fig. 10 Typical Junction Capacitance

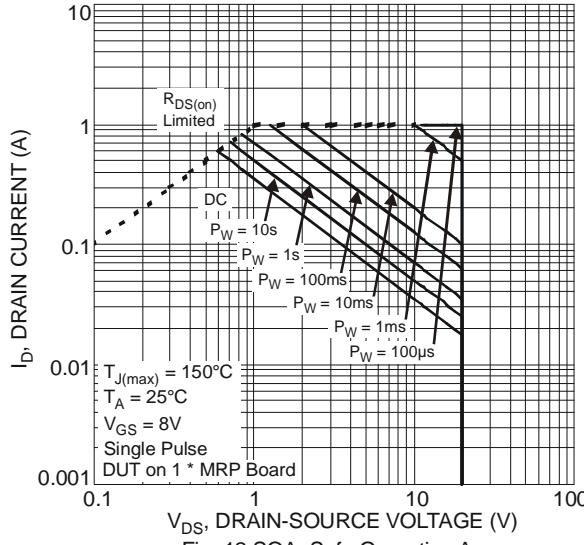
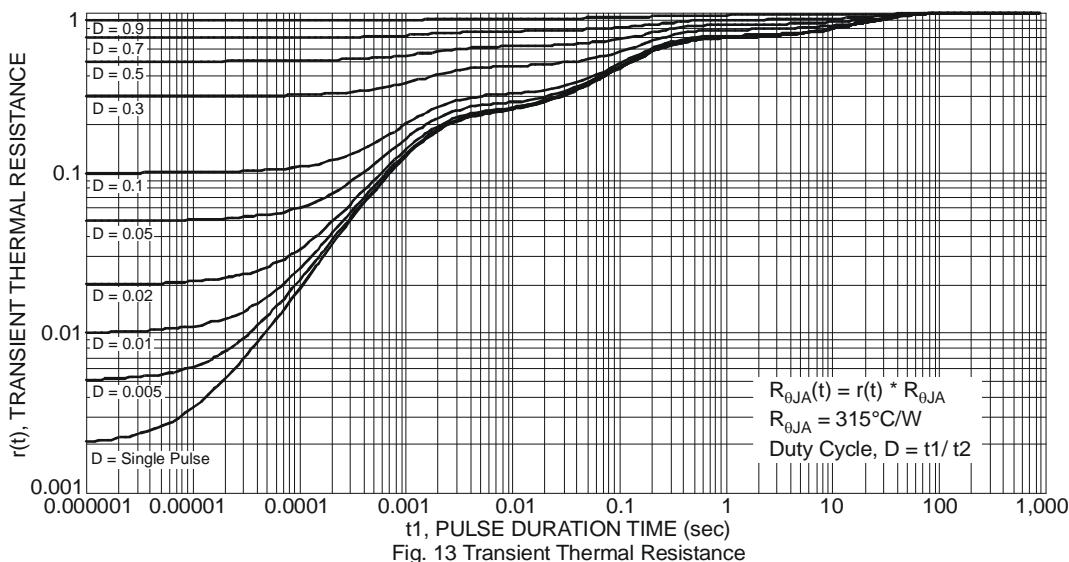
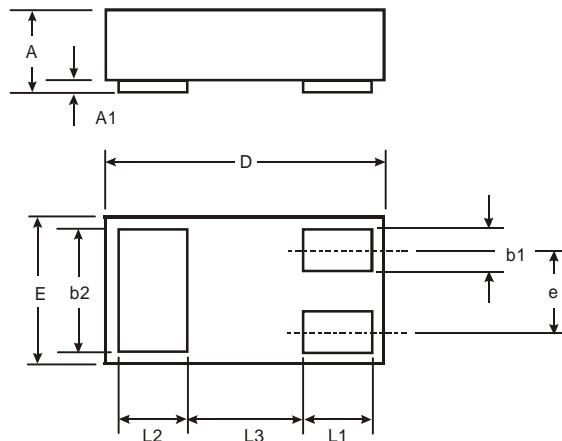


Fig. 12 SOA, Safe Operation Area



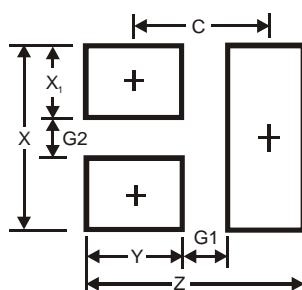
Package Outline Dimensions



X1-DFN1006-3			
Dim	Min	Max	Typ
A	0.47	0.53	0.50
A1	0	0.05	0.03
b1	0.10	0.20	0.15
b2	0.45	0.55	0.50
D	0.95	1.075	1.00
E	0.55	0.675	0.60
e	—	—	0.35
L1	0.20	0.30	0.25
L2	0.20	0.30	0.25
L3	—	—	0.40

All Dimensions in mm

Suggested Pad Layout



Dimensions	Value (in mm)
Z	1.1
G1	0.3
G2	0.2
X	0.7
X1	0.25
Y	0.4
C	0.7

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